IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor Vishnu K. Agarwal Assignee Micron Technology, Inc. Examiner Y. Huynh

Title: Capacitor Constructions with Enhanced Surface Area

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

References –See Attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

This Supplemental Information Disclosure Statement is being filed together with the filing of a Request for Continued Examination (RCE) Application and before receipt of the first Office Action. Therefore, no fee is believed to be required. However, in the event that a fee is required for filing this Supplemental Information Disclosure Statement, please charge the fee specified under 37 C.F.R. §1.17(p) to Deposit Account No. 23-0925. Please credit Deposit Account No. 23-0925 with any overpayment of the above fee.

Citation of the referenced art is respectfully requested.

Respectfully submitted,

Dated: 24Nov 28

Reg. No. 44,854

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8				U.S. PATENT DOCUMENTS					
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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. MI22-1913 SERIAL NO. 10/050,334 PTO-1449 APPLICANT Vishnu K. Agarwal et al LIST OF ART CITED BY APPLICANT (Use several sheets if necessary) FILING DATE January 15, 2002 GROUP 2813 U.S. PATENT DOCUMENTS Filing Date If Appropriate Class Document Date Name Subclass *Examiner Initial Number 07/2003 10/624,340 McClure AA Derderian (as maneded 5/28/02, 10/22/02, 7/25/03, 8/14/03, 1/26/04, 10/4/04) 08/2000 ΑB 09/653,149 AC AD ΑE ΑF AG AΗ ΑI ΑJ ΑK AL FOREIGN PATENT DOCUMENTS Document Number Date Class Subclass Translation Country AM AN ΑO ΑP AQ OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) AR AS ΑT **EXAMINER** DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not

considered. Include copy of this form with next communication to applicant.